



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Jun Koyama et al.                      Art Unit : 2871  
Serial No. : 10/620,565                              Examiner : Unknown  
Filed : July 17, 2003  
Title : SEMICONDUCTOR DEVICE AND MANUFACTURING METHOD THEREOF

**MAIL STOP AMENDMENTS**

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

**SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT AND NOTICE OF  
RELATED APPLICATIONS**

Supplemental to an information disclosure statement filed November 22, 2004,  
Applicants submit full translations of Japan Patent Nos. JP04-313729, JP05-053127, JP05-  
241200, JP06-160904, and JP07-175038. The translations of each of these references are  
enclosed.


Applicants also wish to bring to the Examiner's attention related application Serial Nos.  
10/803,965, filed March 19, 2004, 10/850,117, filed May 21, 2004, and 10/960,897, filed  
October 8, 2004.

This statement is being filed before the receipt of a first Office Action on the merits.  
Please apply any charges or credits to Deposit Account No. 06-1050.

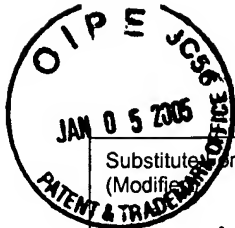
Respectfully submitted,

Date: January 5, 2005

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(Modified)U.S. Department of Commerce  
Patent and Trademark OfficeAttorney's Docket No.  
07977-209003Application No.  
10/620,565**Information Disclosure Statement  
by Applicant**

(Use several sheets if necessary)

(37 CFR §1.98(b))

Applicant  
Jun Koyama et al.Filing Date  
July 17, 2003Group Art Unit  
2871**U.S. Patent Documents**

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	10/803,965	Pending	KOYAMA et al.			03/19/2004
	AB	10/850,117	Pending	KOYAMA et al.			05/21/2004
	AC	10/960,897	Pending	KOYAMA et al.			10/08/2004
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

**Foreign Patent Documents or Published Foreign Patent Applications**

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AL	JP04-313729	05 NOV 1992	JAPAN			Full	
	AM	JP05-053127	05 MAR 1993	JAPAN			Full	
	AN	JP05-241200	21 SEPT 1993	JAPAN			Full	
	AO	JP06-160904	07 JUNE 1994	JAPAN			Full	
	AP	JP07-175038	14 JULY 1995	JAPAN			Full	

**Other Documents (include Author, Title, Date, and Place of Publication)**

Examiner Initial	Desig. ID	Document
	AQ	
	AR	
	AS	
	AT	

Examiner Signature

Date Considered

EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.